

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination GUO ET AL.	
		Examiner S. Devi, Ph.D.	Art Unit 1645	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,866,845	03-2005	Ward et al.	424/139.1
	B	US-			
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	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	EP 0 245 993	11-1987	Europe	Lerrick et al.	
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NON-PATENT DOCUMENTS

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	U	Huber-Lang et al. The FASEB J. 16: 1567-1574, October 2002.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.